Application/Control No. Applicant(s)/Patent Under Reexamination 10/674,292 HASEI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1734 Yewebdar T. Tadesse **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,198,816	04-2007	Masuda et al.	427/97.3
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-		300	
	G	US-			
	r	US-		-	
	_	US-			
	7	US-			
	К	US-			
	٦	US-		·	
	Μ	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					,
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	8	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.